Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/685,941	CHANG ET AL.	
Examiner	Art Unit	
Brian S. Kwon	1614	

	SEAR	CHED	
Class	Subclass	Date	Examiner
574	393 395 397 236.2 238.5	11/30/05	
	39f		
	397		
	ح ، کالی		
	238.5		
	218.g		
	64) 249		
	643		,

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
STN. 5.1. MPL	1/18/25	
- Contract date - someth Nand Sent		
- (ef. 10/26790 call	Confrish	ethod) ch. pen
	·	